

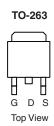
F9630S-VB Datasheet P-Channel 200 V (D-S) MOSFET

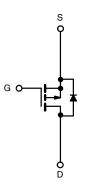
PRODUCT SUMMARY				
V _{DS} (V)	-200			
R _{DS(on)} (Ω)	$V_{GS} = -10 \text{ V}$	0.50		
Q _g max. (nC)	44			
Q _{gs} (nC)	7.1			
Q _{gd} (nC)	27			
Configuration	Single			

FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- P-channel
- · Fast switching
- Ease of paralleling
- Simple drive requirements







P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (To	= 25 °C, unle	ess otherwis	e noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	-200	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V _{GS} at -10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	- I _D	-11		
		T _C = 100 °C		-6.8	Α	
Pulsed Drain Current ^a			I _{DM}	-44		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy b			E _{AS}	700	mJ	
Repetitive Avalanche Current a			I _{AR}	-11	Α	
Repetitive Avalanche Energy ^a			E _{AR}	13	mJ	
Maximum Power Dissipation	T _C = 2	25 °C	P_{D}	125	W	
Peak Diode Recovery dV/dt c			dV/dt	-5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Soldering Recommendations (Peak temperature) ^d	for 10 s			300		
Managhar Tana	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD}=$ -50 V, starting $T_J=25$ °C, L = 8.7 mH, $R_g=25$ Ω , $I_{AS}=$ -11 A (see fig. 12). c. $I_{SD}\leq$ -11 A, dl/dt \leq 150 A/µs, $V_{DD}\leq$ V_{DS} , V_{DS} 0 °C.

- d. 1.6 mm from case.



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TES	TEST CONDITIONS		TYP.	MAX.	UNIT
Static		•			Į.		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$		-200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = -1 mA	-	-0.2	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}		· V _{GS} , I _D = -250 μA	-2.0	-	-4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 \text{ V}$		-	± 100	nA
, and the second		V _{DS} =	V _{DS} = -200 V, V _{GS} = 0 V		-	-100	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -160 \	V _{DS} = -160 V, V _{GS} = 0 V, T _J = 125 °C		-	-500	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = -10 V	I _D = -6.6 A ^b	-	0.50	-	Ω
Forward Transconductance	9 _{fs}		-50 V, I _D = -6.6 A ^b	4.1	-	-	S
Dynamic		•				•	
Input Capacitance	C _{iss}	$V_{GS} = 0 V$,		-	1200	-	pF
Output Capacitance	C _{oss}	7	$V_{DS} = -25 \text{ V},$		370	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	81	-	
Total Gate Charge	Qg			-	-	44	nC
Gate-Source Charge	Q _{gs}	V _{GS} = -10 V	$I_D = -11 \text{ A}, V_{DS} = -160 \text{ V},$ see fig. 6 and 13 b	-	-	7.1	
Gate-Drain Charge	Q _{gd}	1	See lig. 6 and 13	-	-	27	
Turn-On Delay Time	t _{d(on)}			-	14	-	
Rise Time	t _r	V _{DD} =	V _{DD} = -100 V, I _D = -11 A		43	-	- ns
Turn-Off Delay Time	t _{d(off)}	$R_g = 9.1 \Omega$, $R_D = 8.6 \Omega$, see fig. 10 b		-	39	-	
Fall Time	t _f			-	38	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	- nH
Gate Input Resistance	R_g	f = 1 MHz, open drain		0.3	-	1.7	Ω
Drain-Source Body Diode Characteristic					l .		
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p -n junction diode		-	-	-11	_
Pulsed Diode Forward Current ^a	I _{SM}			-	-	-44	A
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = -11 \text{A}, V_{GS} = 0 \text{V} ^{\text{b}}$		-	-	-5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = -11 A, dI/dt = 100 A/μs b		-	250	300	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.9	3.6	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)					L _D)

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 μs ; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

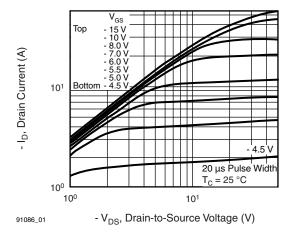


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

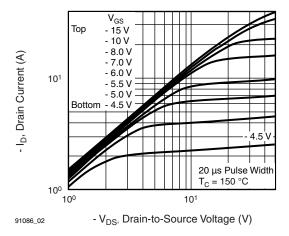


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

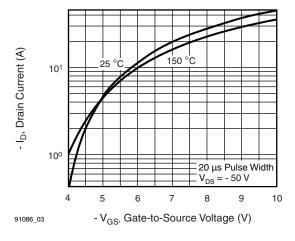


Fig. 3 - Typical Transfer Characteristics

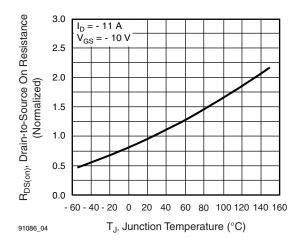


Fig. 4 - Normalized On-Resistance vs. Temperature

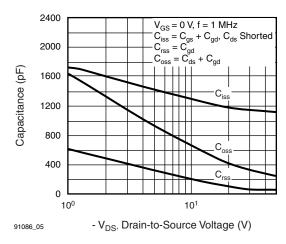


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

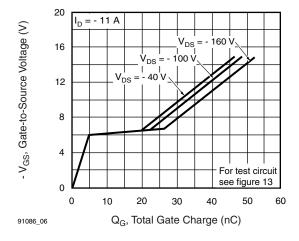


Fig. 6 - Typical Gate Charge vs. Drain-to-Source Voltage



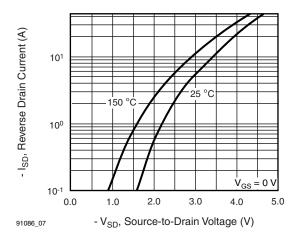


Fig. 7 - Typical Source-Drain Diode Forward Voltage

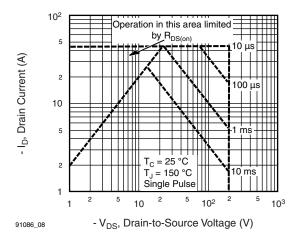


Fig. 8 - Maximum Safe Operating Area

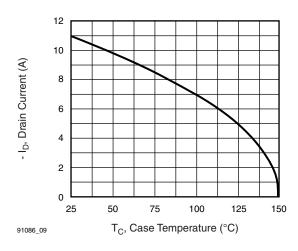


Fig. 9 - Maximum Drain Current vs. Case Temperature

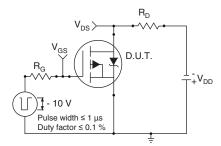


Fig. 10a - Switching Time Test Circuit

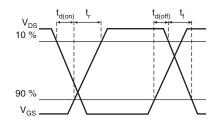


Fig. 10b - Switching Time Waveforms

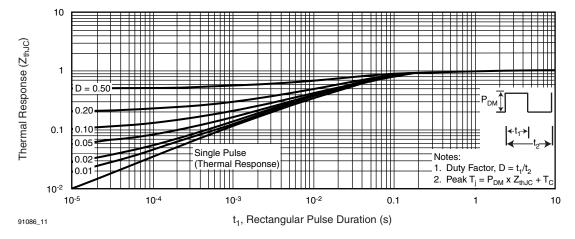
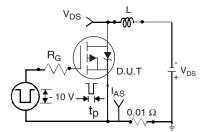
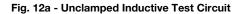


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case







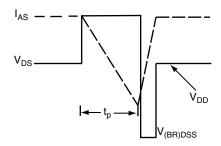


Fig. 12b - Unclamped Inductive Waveforms

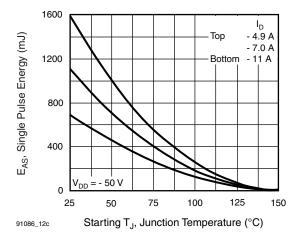


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

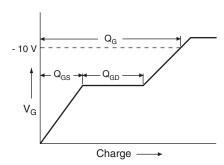


Fig. 13a - Basic Gate Charge Waveform

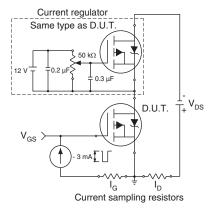
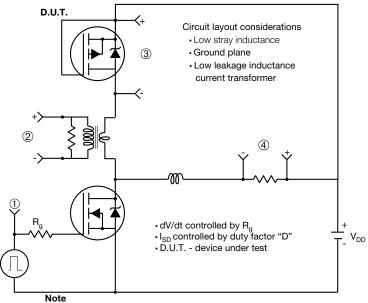


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

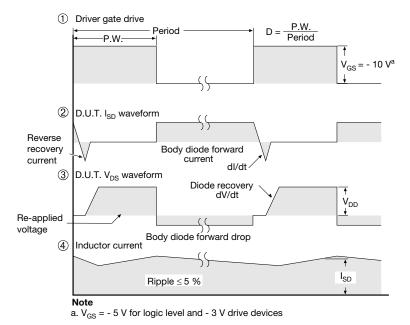
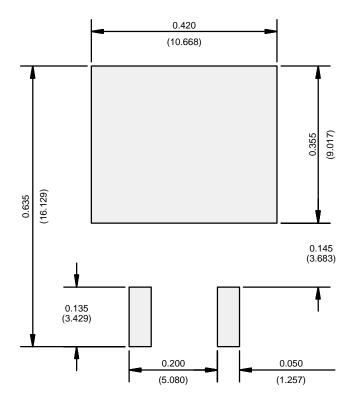


Fig. 14 - For P-Channel



RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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